


|  |  |  |
|--|--|--|
| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10687629 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>INOUE, SATOSHI |
|  | <b>Examiner</b><br><br>Daniel Pan              | <b>Art Unit</b><br><br>2183  |

| SEARCHED |          |          |          |
|----------|----------|----------|----------|
| Class    | Subclass | Date     | Examiner |
| 712      | 33, 225  | 02/22/08 | dp       |

| SEARCH NOTES                           |          |          |
|--|----------|----------|
| Search Notes                           | Date     | Examiner |
| East PGP USPAT JPOABS DERWENT IEEE IBM | 02/22/08 | dp       |
| 710/22,23,711/12                       | 02/22/08 | dp       |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |